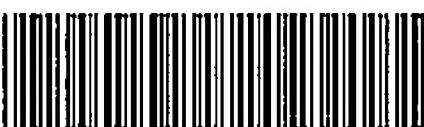


Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10517219	CHRISTEN, YVES
	Examiner Chen, Catheryne	Art Unit 1655

SEARCHED

Class	Subclass	Date	Examiner
none	none	3/14/07	cc

SEARCH NOTES

Search Notes	Date	Examiner
invetor name, USPT, PGPB, JPAB, EPAB, DWPI, Medline, Embase, Bisosis, Caplus, Registryn	3/14/07	cc

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner